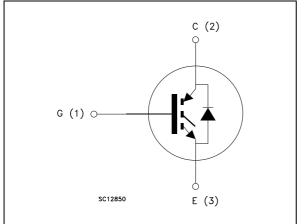


STGW25H120DF2

Trench gate field-stop IGBT, H series 1200 V, 25 A high speed

TO-247

Figure 1. Internal schematic diagram



0 v, 25 A night speed

Datasheet - production data

Features

- Maximum junction temperature: T_J = 175 °C
- High speed switching series
- Minimized tail current
- V_{CE(sat)} = 2.1 V (typ.) @ I_C = 25 A
- 5 μs minimum short circuit withstand time at $T_J{=}150~^\circ C$
- Safe paralleling
- Very fast recovery antiparallel diode
- Low thermal resistance
- Lead free package

Applications

- Uninterruptible power supply
- Welding machines
- Photovoltaic inverters
- Power factor correction
- High frequency converters

Description

This device is an IGBT developed using an advanced proprietary trench gate field stop structure. The device is part of the H series of IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converters. Moreover, a slightly positive $V_{CE(sat)}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

Order code	Marking	Package	Packaging
STGW25H120DF2	GW25H120DF2	TO-247	Tube

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This is information on a product in full production.

Contents

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3	Test circuits
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1 Electrical ratings

Symbol	Parameter	Value	Unit	
V _{CES}	Collector-emitter voltage ($V_{GE} = 0$)	1200	V	
	Continuous collector current at $T_C = 25 \text{ °C}$	50	А	
Ι _C	Continuous collector current at T _C = 100 °C	25	А	
I _{CP} ⁽¹⁾	Pulsed collector current	100	А	
V _{GE}	Gate-emitter voltage	±20	V	
	Continuous collector current at $T_C = 25 \text{ °C}$	50	А	
١ _F	Continuous collector current at T _C = 100 °C	25	А	
I _{FP} ⁽¹⁾	Pulsed forward current	100	А	
P _{TOT}	Total dissipation at $T_{C} = 25 \text{ °C}$	375	W	
TJ	Operating junction temperature	– 55 to 175	ാം	
T _{STG}	Storage temperature range	– 55 to 150		

Table 2. Absolute maximum ratings

1. Pulse width limited by maximum junction temperature.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance junction-case IGBT	0.4	°C/W
R _{thJC}	Thermal resistance junction-case diode	1.47	°C/W
R _{thJA}	Thermal resistance junction-ambient	50	°C/W



2 Electrical characteristics

 $T_J = 25$ °C unless otherwise specified.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage (V _{GE} = 0)	I _C = 2 mA	1200			V
		V _{GE} = 15 V, I _C = 25 A		2.1	2.6	
Vorteen	Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 25 A T _J = 125 °C		2.4		V
		V _{GE} = 15 V, I _C = 25 A T _J = 175 °C		2.5		
		I _F = 25 A		3.8	4.9	
V _F	Forward on-voltage	I _F = 25 A, T _J = 125 °C		3.05		V
		I _F = 25 A, T _J = 175 °C		2.8		
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 1 \text{ mA}$	5	6	7	V
I _{CES}	Collector cut-off current $(V_{GE} = 0)$	V _{CE} = 1200 V			25	μA
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	V _{GE} = ± 20 V			250	nA

Table 5.	Dynamic characteristics
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies}	Input capacitance		-	2010	-	pF
C _{oes}	Output capacitance	V _{CE} = 25 V, f = 1 MHz,	-	146	-	pF
C _{res}	Reverse transfer capacitance	$V_{GE} = 0$	-	49	-	pF
Qg	Total gate charge		-	100	-	nC
Q _{ge}	Gate-emitter charge	V _{CC} = 960 V, I _C = 25 A, V _{GE} = 15 V, see <i>Figure</i> 29	-	11	-	nC
Q _{gc}	Gate-collector charge	GL , storigato Lo	-	52	-	nC



	Table 6. IGBT switching characteristics (inductive load)					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	29	-	ns
t _r	Current rise time		-	12	-	ns
(di/dt) _{on}	Turn-on current slope		-	1774	-	A/µs
t _{d(off)}	Turn-off delay time	$V_{CE} = 600 \text{ V}, I_C = 25 \text{ A},$		130	-	ns
t _f	Current fall time	$R_G = 10 \Omega$, V _{GE} = 15 V, see <i>Figure 28</i>	-	106	-	ns
E _{on} ⁽¹⁾	Turn-on switching losses		-	0.6	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses		-	0.7	-	mJ
E _{ts}	Total switching losses		-	1.3	-	mJ
t _{d(on)}	Turn-on delay time		-	27.5	-	ns
t _r	Current rise time		-	13.5	-	ns
(di/dt) _{on}	Turn-on current slope			1522	-	A/µs
t _{d(off)}	Turn-off delay time	$V_{CE} = 600 \text{ V}, I_C = 25 \text{ A},$	-	139	-	ns
t _f	Current fall time	R _G = 10 Ω, V _{GE} = 15 V, T _{.I} = 175 °C, see <i>Figure</i> 28	-	200	-	ns
E _{on} ⁽¹⁾	Turn-on switching losses		-	1.05	-	mJ
$E_{off}^{(2)}$	Turn-off switching losses		-	1.65	-	mJ
E _{ts}	Total switching losses		-	2.7	-	mJ
t _{sc}	Short-circuit withstand time	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$ T _J = 150 °C,	5		-	μJ

Table 6. IGBT switching characteristics (inductive load)

1. Energy losses include reverse recovery of the external diode. The diode is the same of the co-packed STGW25H120DF2

2. Turn-off losses include also the tail of the collector current.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{rr}	Reverse recovery time		-	303	-	ns
Q _{rr}	Reverse recovery charge		-	0.93	-	μC
I _{rrm}	Reverse recovery current	I _F = 25 A, V _R = 600 V, di/dt=500 A/µs, V _{GF} = 15 V,	-	15.3	-	А
dl _{rr/} /dt	Peak rate of fall of reverse recovery current during t_b	see Figure 28	-	400	-	A/µs
E _{rr}	Reverse recovery energy		-	0.52	-	mJ
t _{rr}	Reverse recovery time		-	508	-	ns
Q _{rr}	Reverse recovery charge		-	2.71	-	μC
I _{rrm}	Reverse recovery current	I _F = 25 A, V _R = 600 V, di/dt=500 A/µs, V _{GE} = 15 V,	-	23	-	А
dI _{rr/} /dt	Peak rate of fall of reverse recovery current during t _b	$T_J = 175 ^{\circ}C$, see <i>Figure 28</i>	-	680	-	A/µs
E _{rr}	Reverse recovery energy		-	1.56	-	mJ

Table 7. Diode switching characteristics (inductive load)



2.1 Electrical characteristics (curves)

Figure 2. Power dissipation vs. case temperature

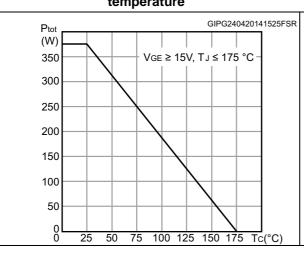


Figure 4. Output characteristics $(T_J = 25^{\circ}C)$

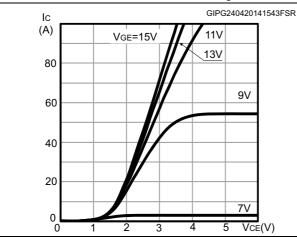
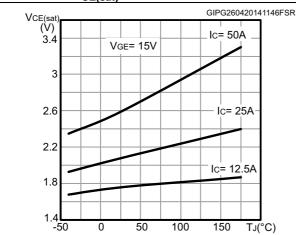


Figure 6. V_{CE(sat)} vs. junction temperature



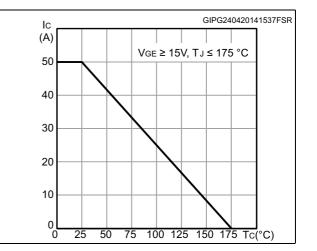


Figure 3. Collector current vs. case temperature



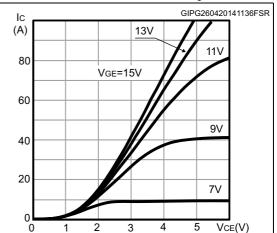


Figure 7. V_{CE(sat)} vs. collector current

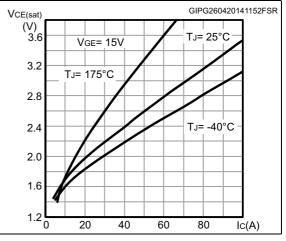






Figure 8. Collector current vs. switching frequency

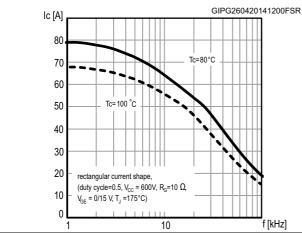


Figure 10. Transfer characteristics

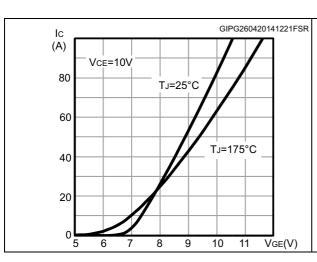


Figure 12. Normalized V_{(BR)CES} vs. junction temperature

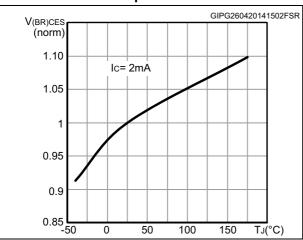


Figure 9. Forward bias safe operating area

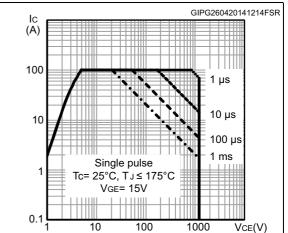


Figure 11. Normalized V_{GE(th)} vs junction temperature

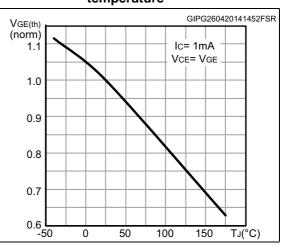
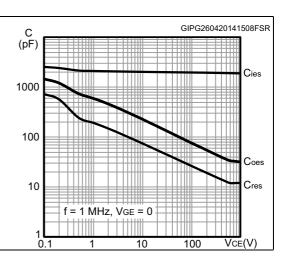


Figure 13. Capacitance variation





GIPG270420141036FSR

EON

40

50

Ic(A)

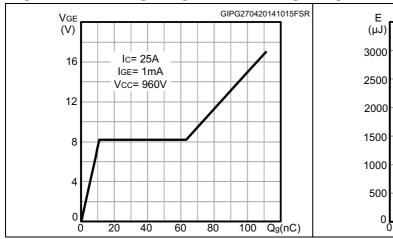
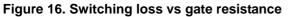
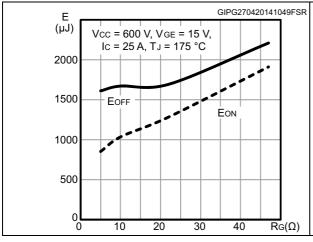


Figure 14. Gate charge vs. gate-emitter voltage Figure 15. Switching loss vs collector current







30

20

10

Vcc = 600V, Vge = 15V, Rg = 10Ω, TJ = 175°C

EOFF

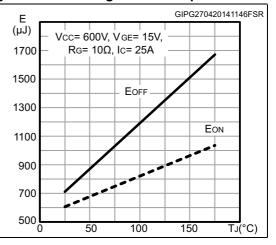
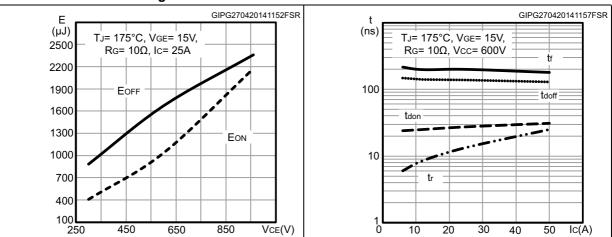


Figure 18. Switching loss vs collector-emitter Figure voltage

Figure 19. Switching times vs. collector current



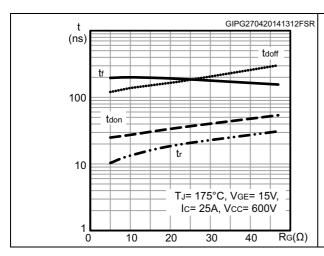


Figure 20. Switching times vs. gate resistance Figure 21. Reverse recovery current vs. diode

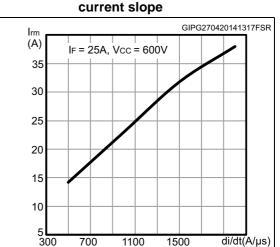


Figure 22. Reverse recovery time vs. diode current slope

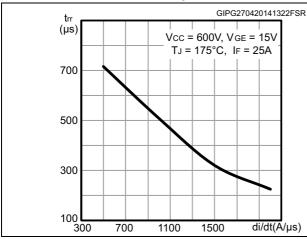
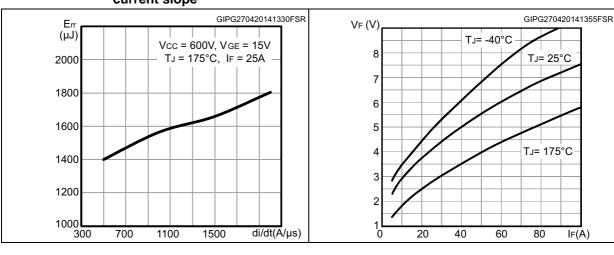
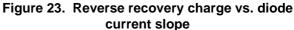


Figure 24. Reverse recovery energy vs. diode current slope



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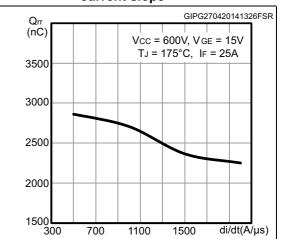


Figure 25. Diode V_F vs. forward current



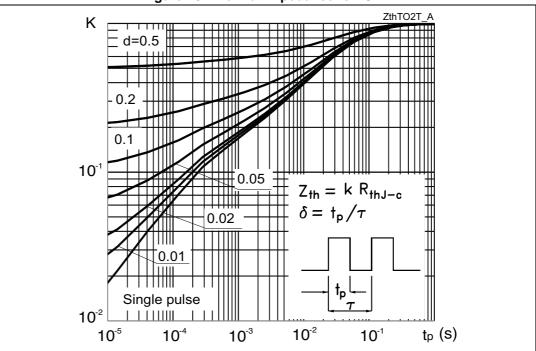
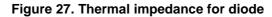
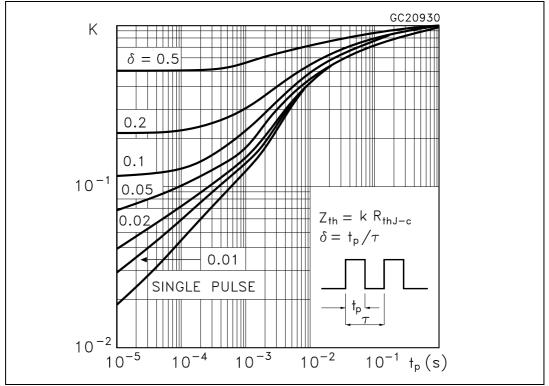


Figure 26. Thermal impedance for IGBT





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3 Test circuits

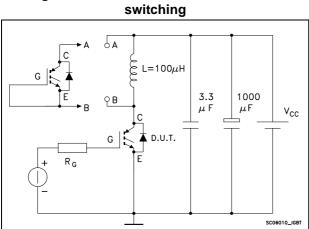


Figure 28. Test circuit for inductive load

12V 47Κ Ω 4 1KΩ ⊥____100nF I_G=CONST $V_i = 20V = V_{GMAX}$ 1ΚΩ - С.U.т. 2200 #F V G 2.7ΚΩ Ó 47K Ω 1KΩ ΄Ρ_w

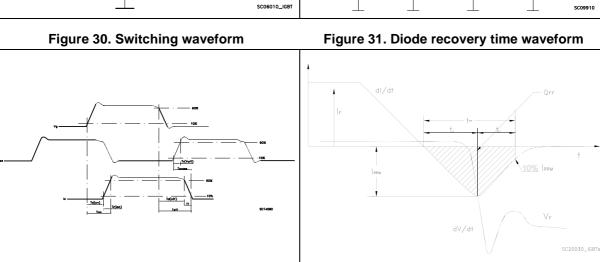
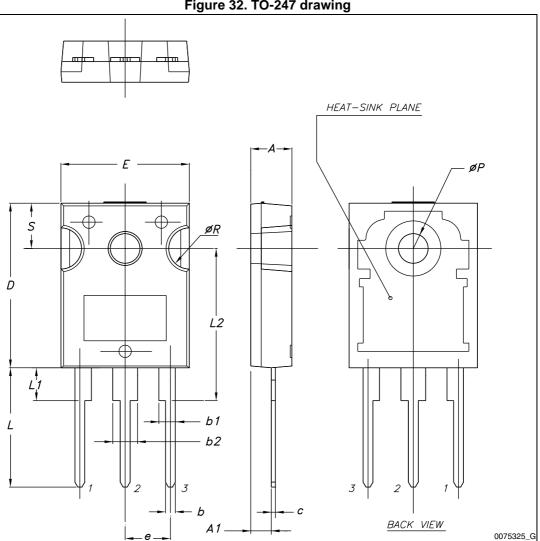


Figure 29. Gate charge test circuit



Package mechanical data 4

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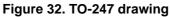




	Table 8. 10-247 mechanical data				
Dim.		mm.			
Dini	Min.	Тур.	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

Table 8. TO-247 mechanical data



5 Revision history

Date	Revision	Changes
03-Oct-2012	1	Initial release.
28-Feb-2014	2	Updated title and features in cover page. Minor text changes.
31-Mar-2014	3	Document status promoted from preliminary to production data. Updated <i>Table 4: Static characteristics</i> and <i>Table 6: IGBT switching</i> <i>characteristics (inductive load)</i> . Added <i>Section 2.1: Electrical characteristics (curves)</i> .

Table 9. Document revision history



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